CLAIMS

- 1. Method of generating line properties of a signal line including generating (401) a frequency dependent line input impedance $(Z_{in}(f))$ for a loop, the loop including the signal line (2) and a remote device (3), the method being characterized by:
- Generating (402) an absolute value function ($|Z_{h}(f)|$, A1) from the frequency dependent line input impedance ($Z_{h}(f)$), the function being essentially periodic;
- Selecting (408) at least two consecutive extreme values $({\tt Max1;Max2}) \ \ {\tt of} \ \ {\tt the} \ \ {\tt same} \ \ {\tt type} \ \ {\tt of} \ \ {\tt the} \ \ {\tt absolute} \ \ {\tt value}$ function ($|Z_n(f)|$);
 - Generating (409) a frequency distance (FD1) based on said at least two extreme values;
- Generating (410) a line length value (L) based on the frequency distance (FD1) and a velocity of propagation (vop) for a signal on the signal line (2).
- 2. Method of generating line properties of a signal line according to claim 1, wherein the frequency distance is a mean value (MV1,MV2,MV3) between at least two different frequency distances (FD1-FD4), each of which reaches between two consecutive ones of the extreme values (Max1,Max2,Max3; Min1,Min2,Min3) of the same type.
- 3. Method of generating line properties of a signal line according to claim 1 or 2, the method being performed as a single ended loop test and including:
 - selecting a test transceiver (31) suitable for communication purposes;

20

WO 2004/099711 PCT/SE2004/000718 22

- connecting (603), in a calibration process, at least three impedances (9) of each a predetermined value to a signal line connection (5) of the test tranceiver (31);
- frequency dependent generating (606)echo functions ($H_{echo}(f)$) utilizing test signals (${\rm vt_{in}}$, ${\rm vt_{out}}$) 5 and said at least three impedances (9); and
- generating (608)transceiver model values $(Z_{h0}(f),Z_{hyb}(f),H_{\infty}(f))$ with the aid of said echo transfer functions $(H_{\it echo}(f))$ and the corresponding impedance values 10 (9), said model values including an echo transfer function $(H_{\omega}(f))$ for the test transceiver (31) with open line connection (5), a transceiver impedance value ($Z_{hb}(f)$) as seen from the line (2) side and a product $(Z_{h0}(f))$ of said transceiver impedance value $(Z_{hb}(f))$ and an echo transfer 15 function $(H_0(f))$ for the transceiver (31) with shortcut line connection (5).
 - 4. Method of generating line properties of a signal line according to claim 3 including storing (609) the transceiver $(Z_{h0}(f), Z_{hvb}(f), H_{\infty}(f))$ values obtained in the calibration process.
 - 5. Method of generating line properties of a signal line according to claim 4 including:
- selecting (610) a transceiver (1) for communication purposes of the same type of hardware as said test 25 transceiver (31) in the calibration process;
 - connecting (701) the loop to the transceiver (1);
 - sending (702), via the connected transceiver (1), a loop test signal (vin) to the line (2);

- measuring (703), via said transceiver (1), the loop test signal (v_{out}) as reflected;
- generating (704) a loop echo transfer function $(H_{echo}(f))$ for the loop (2,3);
- 5 generating (705) the frequency dependent line input impedance value $(Z_{in}(f))$ for the loop (2,3) with the aid of the stored transceiver model values $(Z_{h0}(f), Z_{hyb}(f), H_{\infty}(f))$ and the generated echo transfer function $(H_{schn}(f))$.
- 6. Method of generating line properties of a signal line according to claim 1, 2 or 5, wherein a short loop length decision value (dValue) is estimated, the method including:
 - generating, in a predetermined loop length frequency range (f_1-f_2) , an impedance mean value (mValue) of the absolute value $(|Z_{ln}(f)|)$ of the line input impedance $(Z_{ln}(f))$;
- generating, in the loop length frequency range, the short loop length decision value (dValue) based on the line input impedance ($Z_{in}(f)$) and said impedance mean value- (mValue);
- comparing the short loop length decision value (dValue) with a predetermined threshold value (thValue);
 - deciding the loop to be a short loop based on said comparison.
 - 7. Method of generating line properties of a signal line according to claim 1, 2, 5 or 6 including:
- 25 calculate an average attenuation value (AA1) for a selected set of telecommunication cables;
 - estimate the length (L) of the short signal line (2);

- generate an attenuation value (LA1) for the line (2) by multiplying the average attenuation value (AA1) with the line length (L).
- 8. Method of generating line properties of a signal line according to claim 1, 2, 5 or 6 including:
 - selecting one of the minimum values (Min1) of the absolute value function ($|Z_{ln}(f)|$, A1) and an adjacent of the maximum values;
- generating an insertion loss (loss) value for the line (2) based on said minimum and maximum values.
- 9. An arrangement for generating line properties of a signal line, the arrangement including a front end device (MD1;1) having connections (5) for a loop including the signal line (2) and a remote device (3), the arrangement including circuits (LU1;42,42,43) in the front end device (MD1;1) for generating a frequency dependent line input impedance $(Z_{in}(f))$ for the loop, the arrangement being characterized by:
- a calculation unit(CU1;11) for generating an absolute value function ($|Z_m(f)|$) from the frequency dependent line input impedance ($Z_m(f)$), the function being essentially periodic;
 - circuits in the calculation unit (CU1;11) suitable for:
- a). selecting at least two consecutive extreme values (Max1,Max2) of the same type of the absolute value function ($|Z_{in}(f)|$);
 - b). generating a frequency distance (FD1) based on said at least two extreme values;

- c). generating a line length value (L) based on the frequency distance (FD1) and a velocity of propagation (vop) for a signal on the signal line (2).
- 10. An arrangement for generating line properties of a signal line according to claim 9, wherein the calculation unit (CU1;11) is arranged for calculating a mean value (MV1,MV2,MV3) between at least two different ones of the frequency distances (FD1-FD4), each of which reaches between two consecutive ones of the extreme values (Max1,Max2,Max3; Min1,Min2,Min3) of the same type.
- 11. An arrangement for generating line properties of a signal line (2) according to claim 9 or 10, wherein the front end device is a transceiver (1,31) for communication purposes, the arrangement in a calibration mode including:
 - a test transceiver (31) connected to a measurement device (32);
- the measurement device (32) being arranged to generate, in a calibration process, calibration values for the transceiver (1,31) for communication purposes with the aid of at least three impedances (9) and test signals (vt_{in}, vt_{out}), the impedances (9) having each a predetermined value and being connected to the line connection (5) of the test tranceiver (1, 31);
- the measurement device (32) being arranged to generate a frequency dependent echo transfer function $(H_{echo}(f))$ for the test transceiver (1,31) connected to the respective one of the impedances (9);
- the measurement device (32) being arranged to generate transceiver model values $(Z_{h0}(f), Z_{hyb}(f), H_{\infty}(f))$ with the aid

of said echo transfer function $(H_{echo}(f))$ and the corresponding impedance values (9), said model values including an echo transfer function $(H_{\infty}(f))$ for the transceiver (1, 31) with open line connection (5), a transceiver impedance value $(Z_{hyb}(f))$ as seen from the line (2) side and a product of said transceiver impedance value $(Z_{hyb}(f))$ and an echo transfer function $(H_0(f))$ for the transceiver (1, 31) with shortcut line connection (5); and

- the transceiver for communication purposes (1,31) being arranged to generate the frequency dependent line input impedance $(Z_{ln}(f))$ with the aid of the transceiver model values $(Z_{h0}(f), Z_{hvb}(f), H_{\infty}(f))$.
- 12. An arrangement for generating properties of a signal line (2) according to claim 11, the arrangement including a memory (12, 33) for storing the transceiver model values $(Z_{h0}(f), Z_{hvb}(f), H_{\infty}(f))$.